<table>
<thead>
<tr>
<th>Uncertainty source per channel</th>
<th>dielectron</th>
<th>dimuon</th>
</tr>
</thead>
<tbody>
<tr>
<td>Spurious signal for zero-width [events]</td>
<td>46 – 0.001</td>
<td>44 – 0.03</td>
</tr>
<tr>
<td>Spurious signal for 10% relative width [events]</td>
<td>146 – 0.006</td>
<td>122 – 0.04</td>
</tr>
<tr>
<td>Identification [% of ϵ]</td>
<td>1 – 6</td>
<td>1 – 31</td>
</tr>
<tr>
<td>Isolation [% of ϵ]</td>
<td>0.3 – 1.1</td>
<td>0.5</td>
</tr>
<tr>
<td>Good muon requirement [% of ϵ]</td>
<td>1 – 52</td>
<td></td>
</tr>
<tr>
<td>Luminosity [%]</td>
<td>1.7</td>
<td>1.7</td>
</tr>
<tr>
<td>Energy scale [% of μG]</td>
<td>0.4 – 0.7</td>
<td></td>
</tr>
<tr>
<td>Energy scale [% of μCB]</td>
<td>+0.5 – 1.2</td>
<td></td>
</tr>
<tr>
<td>Electron energy resolution [% of σG]</td>
<td>+17 – 68</td>
<td>-</td>
</tr>
<tr>
<td>Electron energy resolution [% of σCB]</td>
<td>8 – 17</td>
<td></td>
</tr>
<tr>
<td>Muon ID (MS) resolution [% of σG]</td>
<td>-</td>
<td>+1 – 1 ( +4 – 6 )</td>
</tr>
<tr>
<td>Muon ID (MS) resolution [% of σCB]</td>
<td>-</td>
<td>+0 – 3 ( 2 – 8 )</td>
</tr>
</tbody>
</table>